

## Notice of References Cited

Application/Control No.

10/073,304

Examiner

James Phan

Applicant(s)/Patent Under
Reexamination
YASUDA ET AL.

Art Unit
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## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,556,333	04-2003	Tokuda et al.	359/224
	В	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	н	US-			
	ł	US-			
	7	US-			
	К	US-			
	L	US-			
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## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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